

Fascinated Journeys into Blue Light

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- 2. Creation of GaN single crystal with excellent quality**
- 3. Development of GaN p-n junction Blue LEDs and Laser diodes**
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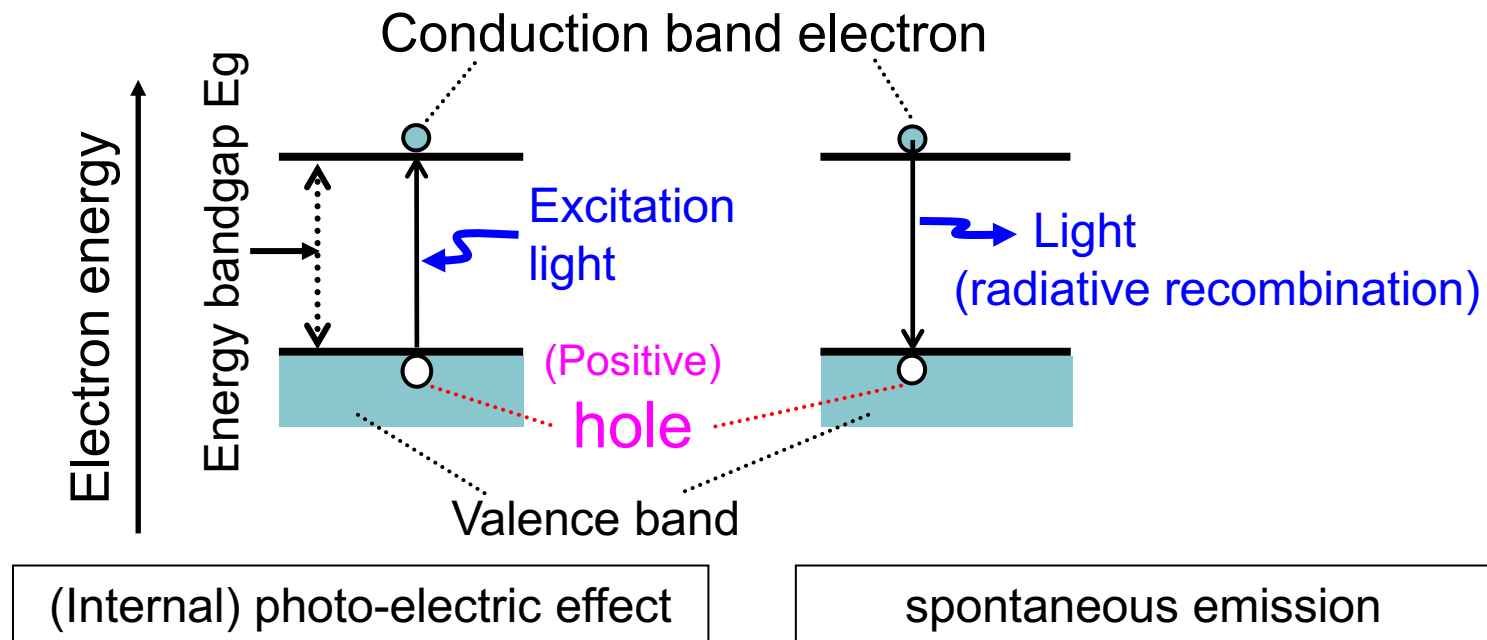
Blue Light-Emitting Devices (LED, Laser diode)

[A] Energy bandgap E_g :

>2.6 eV (< 480 nm) (Wide bandgap semiconductors)

[B] Energy band structure:

Direct-transition type for conservation of electron momentum

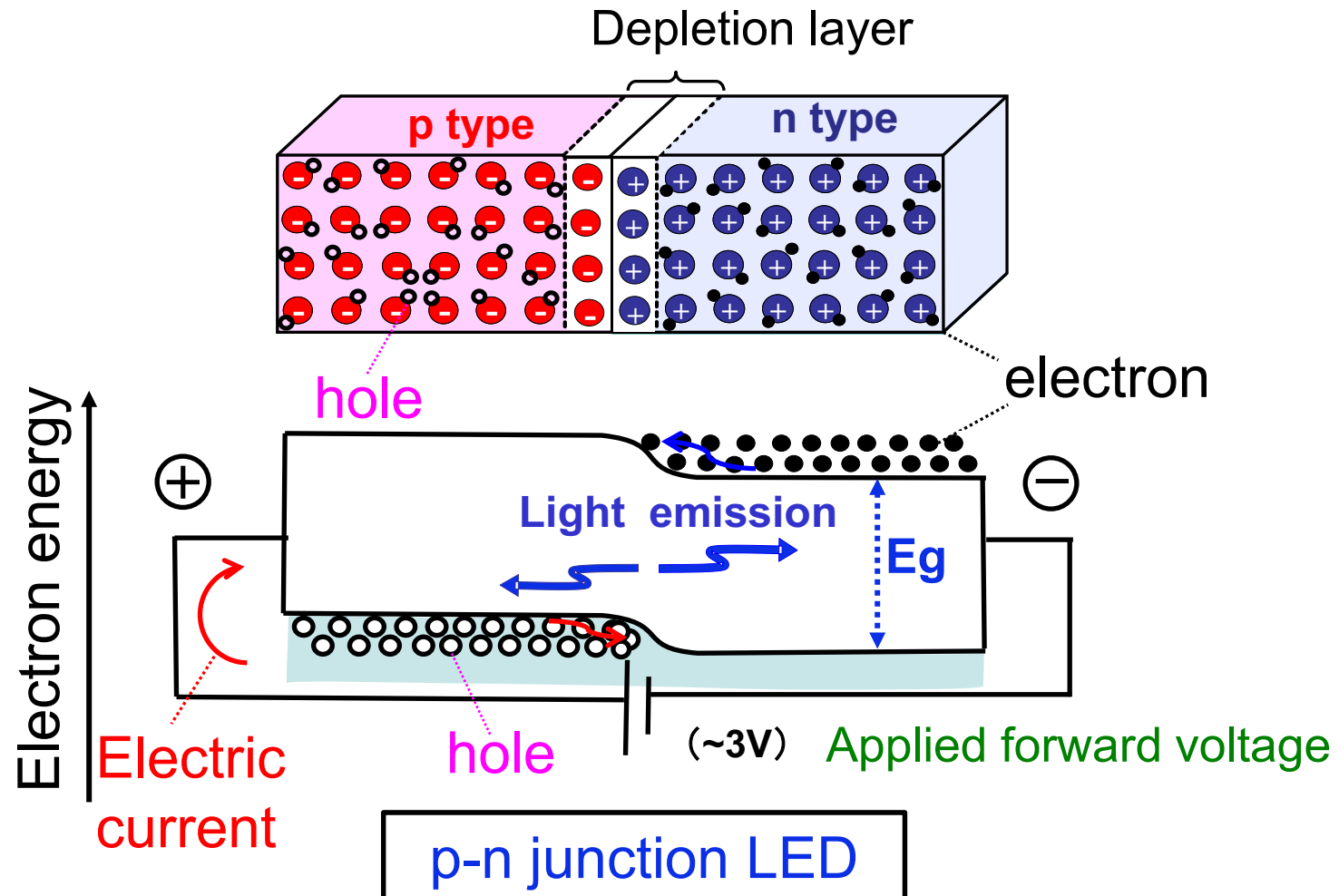


Conservation of energy

High-performance Blue LED and Laser diode

[1] High-quality single crystal

[2] p-n junction



Candidate materials for Blue Light-Emitters in 1960s-'70s

	ZnSe	GaN
[A] Energy gap (E_g)	2.7 eV	3.4 eV
[B] Energy band structure	direct	direct
[1] Crystal growth	straightforward	too difficult
Substrate	GaAs	sapphire
Lattice mismatch	0.26 %	16 %
[2] p-n junction	not realized at that time	
Number of researchers	many	few
Physical & chemical stability	low	high

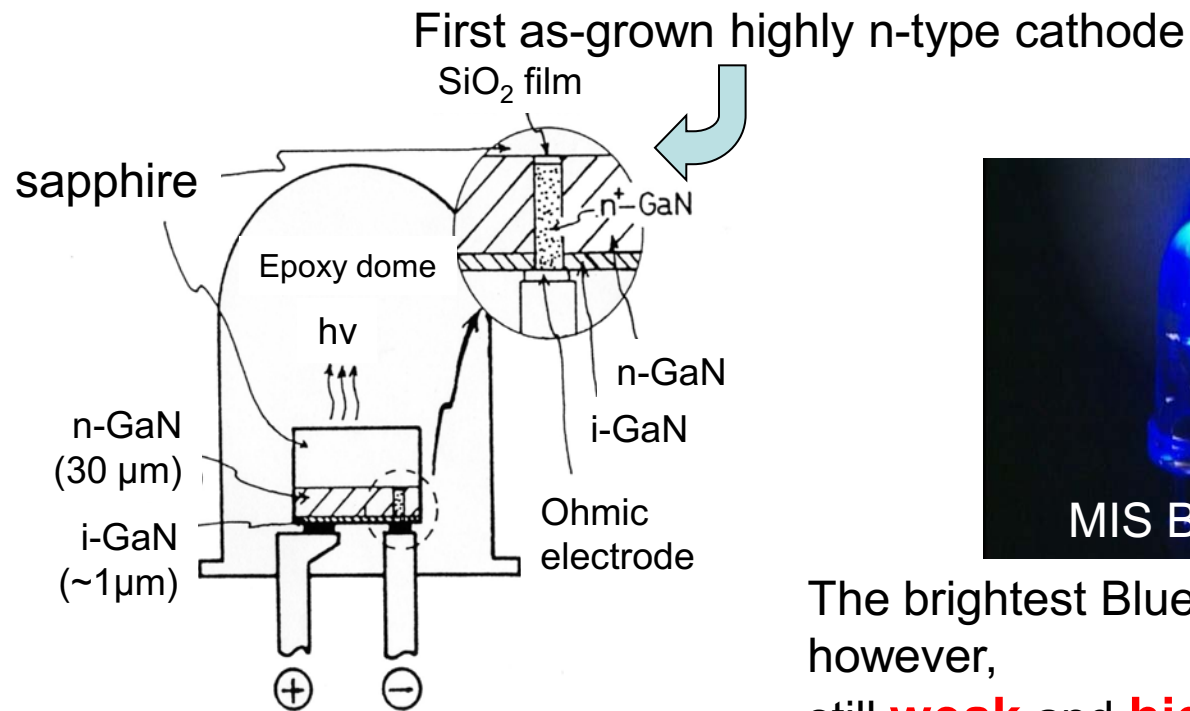
Candidate materials for Blue Light-Emitters in 1960s-'70s

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Chose GaN in 1973 at Matsushita Research Institute Tokyo (**MRIT**)
because of toughness, wider direct E_g , and non-toxicity

Started growth of GaN by MBE in 1973, and by HVPE in 1975

GaN MIS Blue LED by HVPE



MIS Blue LED,
not p-n junction LED

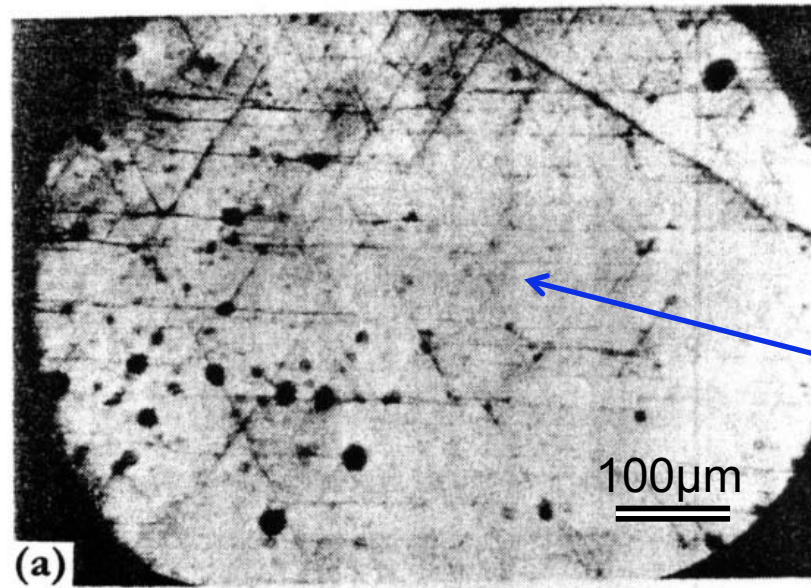


The brightest Blue LED at that time,
however,
still **weak** and **high operating voltage**

at **MRIT**

Potential of GaN

at MRIT



High-quality tiny crystallites

Surface of GaN grown on sapphire by HVPE (1975-78)

Tiny but high-quality crystallites embedded in HVPE-grown crystals



Recognized the great potential of GaN



Made up my mind to go back to the beginning; i.e.
Crystal Growth in 1978

Crystal growth methods for GaN

Hydride Vapor Phase Epitaxy (HVPE)

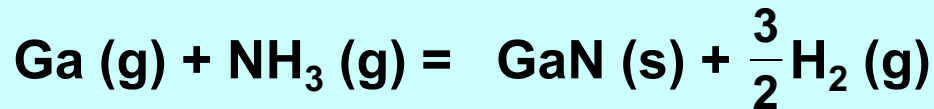
H. P. Maruska and J. J. Tietjen: (1969).



Issues: Susceptible to reverse reactions, Too fast growth rate

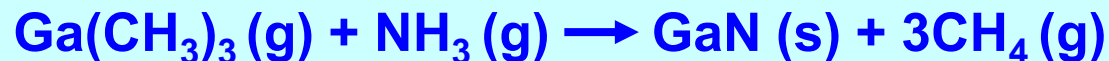
Molecular Beam Epitaxy (MBE)

I. Akasaki: (1974) (unpublished).



Issues: Prone to nitrogen deficiency, Slow growth rate (at that time)

Metalorganic Vapor Phase Epitaxy (MOVPE), (MOCVD) H. M. Manasevit et al: (1971).



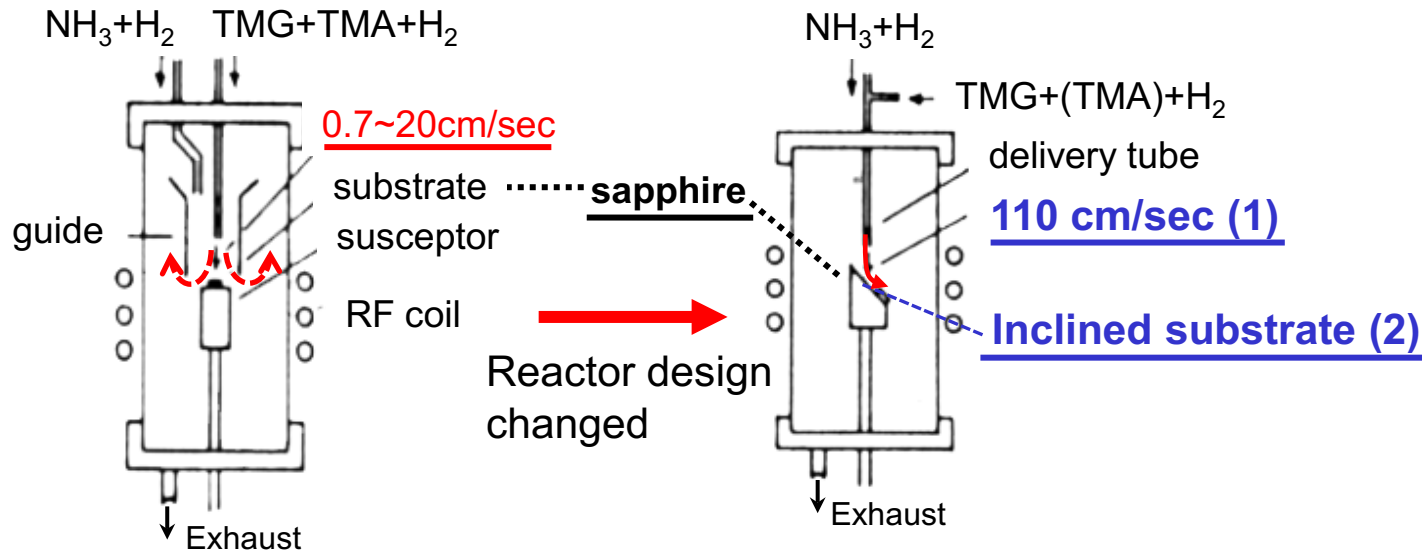
Advantages:

- No reverse reactions
- Easy to control growth rate, alloy (AlGaIn, GaInN) composition, and impurity-doping

Decided to adopt MOVPE (1979) at MRIT

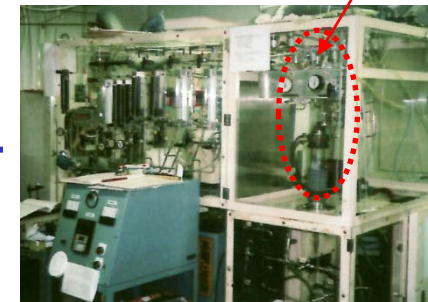
Started anew to MOVPE since 1981 at Nagoya University

Improvements in MOVPE reactor and growth condition (1) (2)



(1985)

Y. Koide

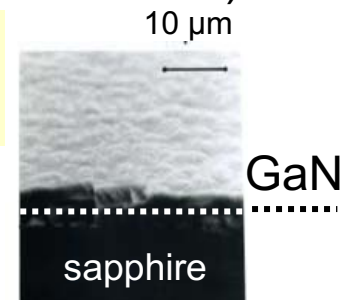


First MOVPE system (Handmade)

Mixing TMG (TMA) with NH_3 just before the reactor inlet, and
(1) High speed gas flow (2) Substrate inclined at a 45-degree angle

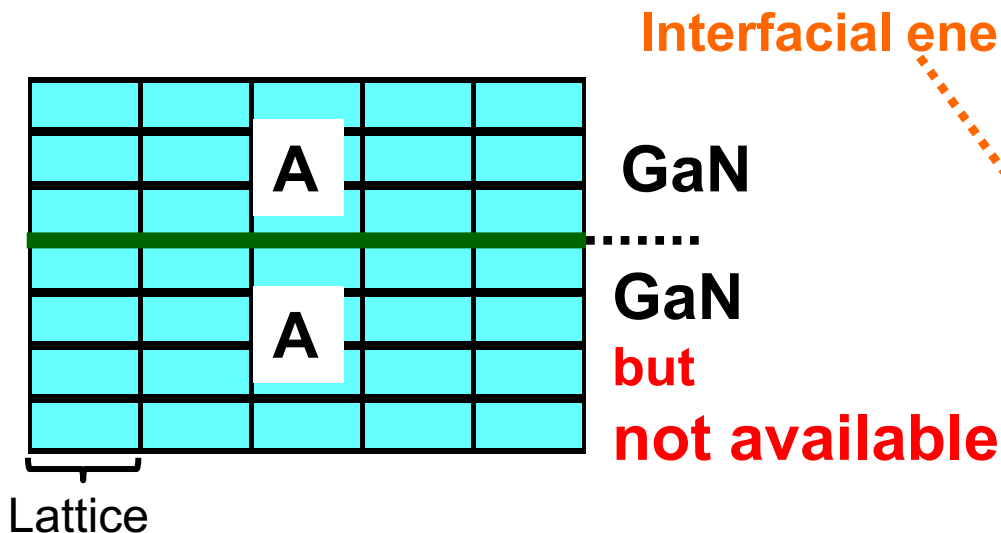
Suppressed the convective gas stream, and the adduct formation

Uniform growth, but not specular surface, still poor material quality



Bird-view SEM image by H. Amano

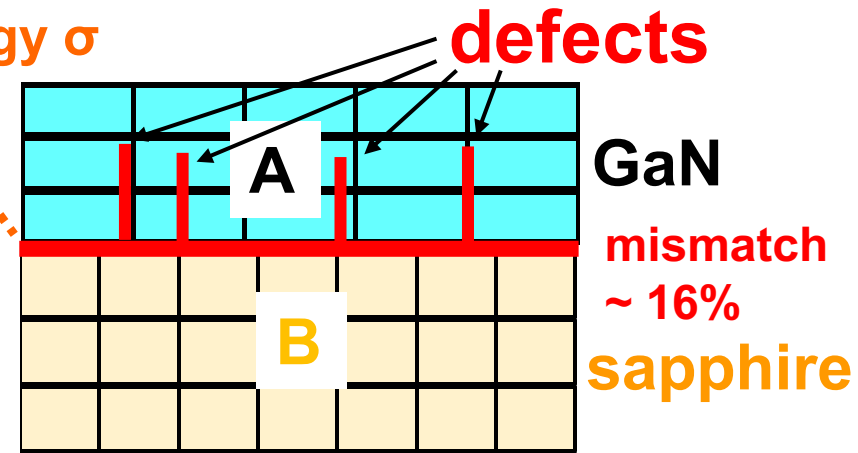
Growth on
the same substrate



Homoepitaxy

Lattice matching

Growth on
a highly-mismatched substrate

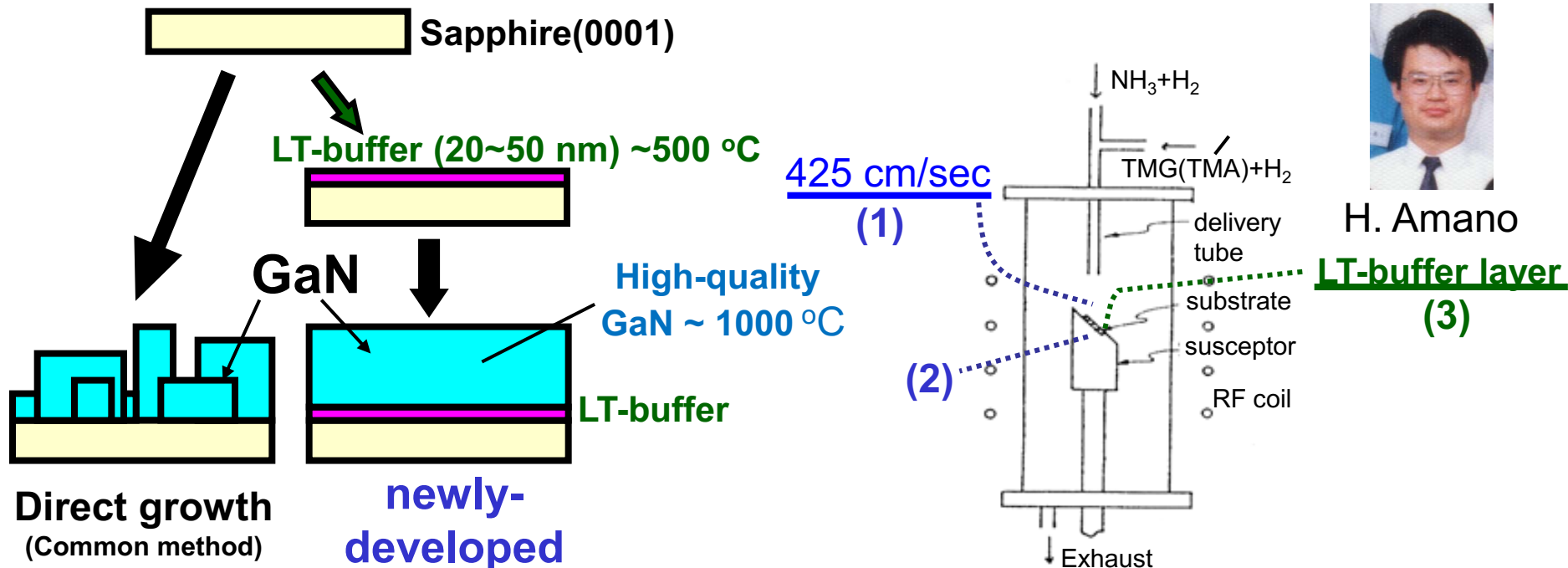


Heteroepitaxy

Huge lattice-mismatch

For epitaxial growth, it is considered to be gospel to have a lattice matching:
(e. g. Si on Si, GaAs on GaAs)

(3) Innovation in MOVPE growth method (1985)

Low-temperature (LT-) buffer layer**Key technologies:**

- (1) Much higher-speed gas flow (425 cm/sec)
- (2) Substrate inclined at a 45-degree angle
- (3) Deposition of thin AlN buffer layer at about 500 °C,
before the growth of GaN single crystal at about 1000 °C

Creation of high-quality GaN (1985)

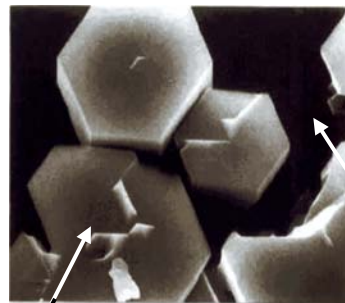
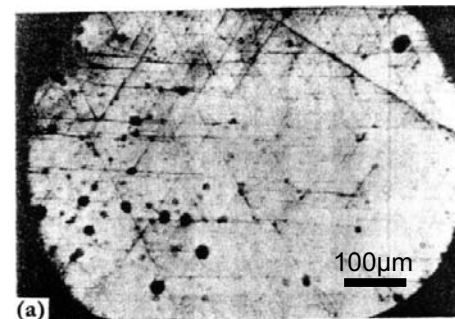
Until 1985

GaN grown by HVPE

GaN grown by MOVPE

Since the late 1985

GaN grown by MOVPE using LT-buffer



Sapphire



2mm

Many cracks, pits

Rough surface

Dislocations: $> 10^{11} \text{ cm}^{-2}$

Free electron conc. $> 10^{19} \text{ cm}^{-3}$

Electron mobility: $\sim 20 \text{ cm}^2/\text{V}\cdot\text{s}$

Weak luminescence

Crack-free, pit-free

Specular surface

Dislocations: $10^8\text{-}10^9 \text{ cm}^{-2}$

Free electron conc. $< 10^{16} \text{ cm}^{-3}$

Electron mobility: $\sim 700 \text{ cm}^2/\text{V}\cdot\text{s}$

Intense luminescence

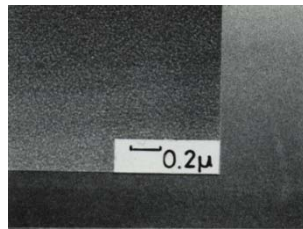
Crystal quality, electrical property, and luminescence property were dramatically improved at the same time

Growth model of GaN using LT-buffer layer

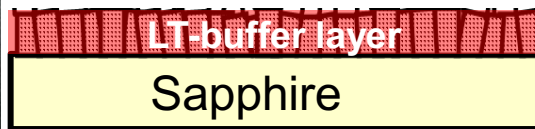
Surface (SEM) images

Growth model

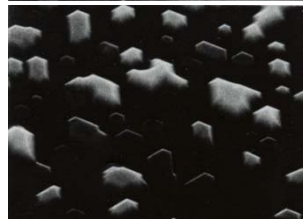
(1) As-deposited
LT-AlN buffer layer



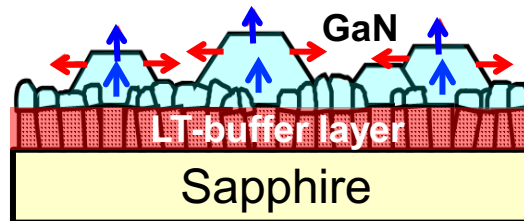
Mixture both amorphous &
fine crystallites of AlN



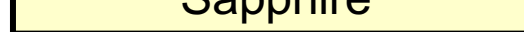
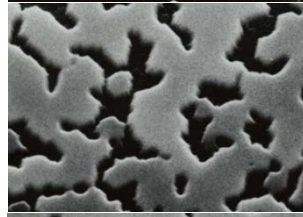
(2) 5 min
GaN growth



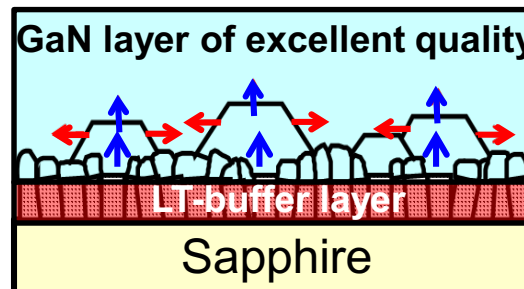
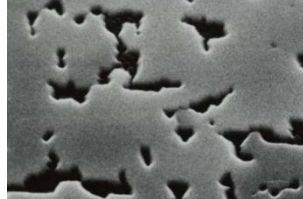
Lateral growth of GaN
dominates



(3) 10 min
GaN growth



(4) 20 min
GaN growth



(5) 60 min
GaN growth



Increase GaN thickness

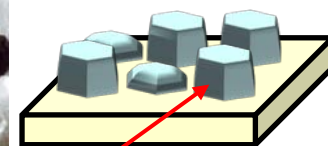
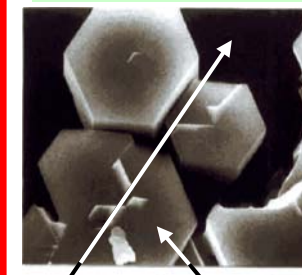


K. Hiramatsu

Direct growth for 60 min. (No LT-buffer)

Surface (SEM) images

Growth model



GaN island

Sapphire (a) 1 μm
GaN island

Realization of p-type GaN, AlGaInN, and GaInN

1986

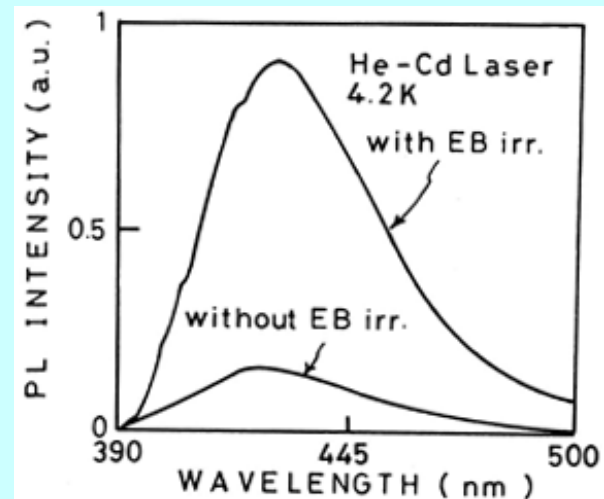
Basic Technology

High-quality GaN using LT-buffer layer
(Low residual impurities)

1988 Found greatly enhanced blue emission of
Zn doped **GaN** by electron irradiation
(LEEBI)



H. Amano



High-quality **Mg-doped**
GaN subjected to LEEBI

1989 Doped **Mg** using **CP₂Mg** and electron
irradiation

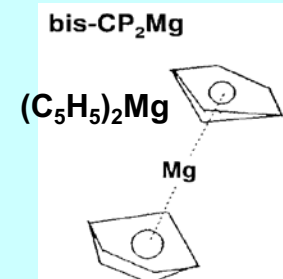
Achieved the first p-type GaN

1991 p-type AlGaIn

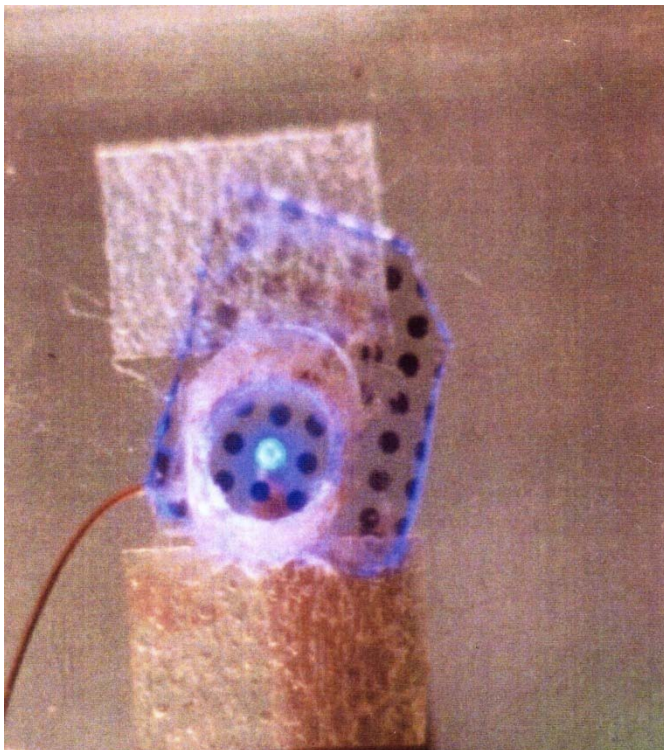
1995 p-type GaInN



M. Kito



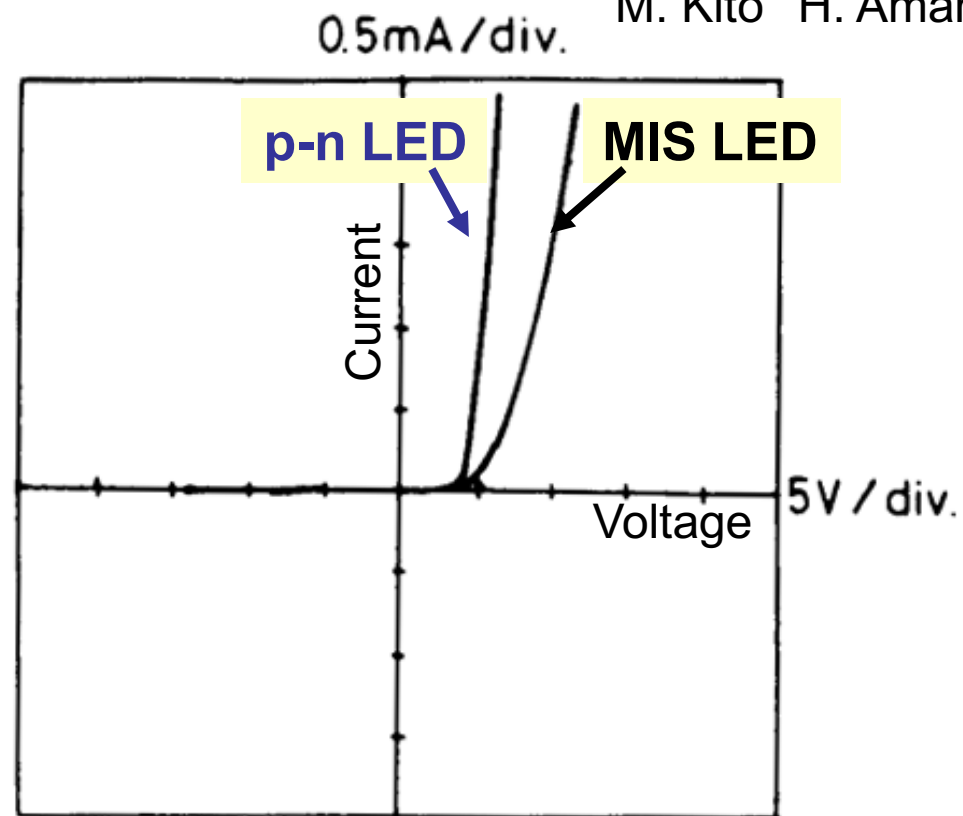
The world's first GaN p-n junction blue LED (1989)



**GaN p-n junction
Blue LED**



M. Kito H. Amano



I-V curves

Conductivity control of n-type GaN, AlGaIn

1986

Basic Technology

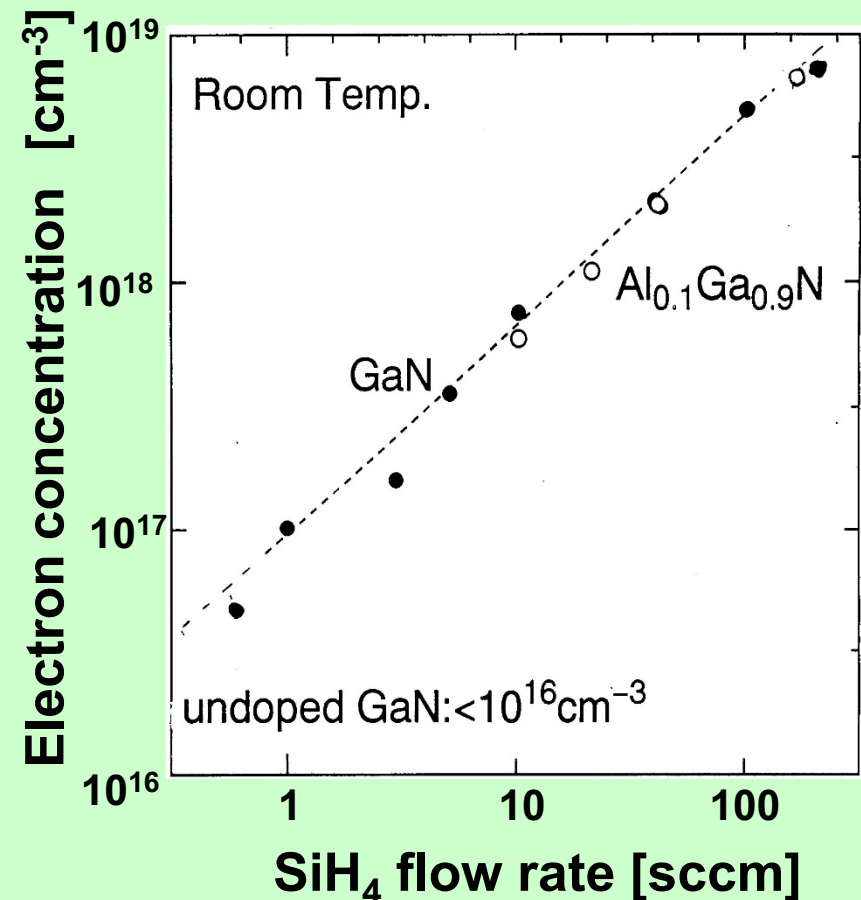
High-quality GaN using LT-buffer layer
(Low residual impurities)

1989 Doped **Si** into high-quality GaN using **SiH₄**

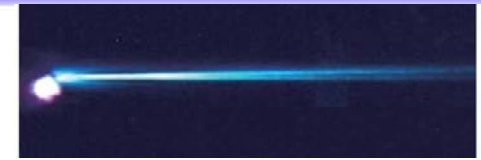
Achieved conductivity control of n-type GaN

1991 n-type AlGaIn

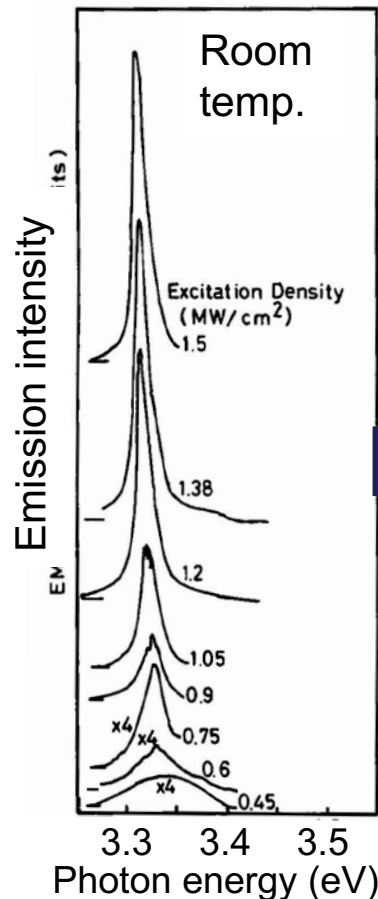
Allowed the use of **heterostructure** and **quantum well** in the design of more efficient p-n junction light-emitting structures



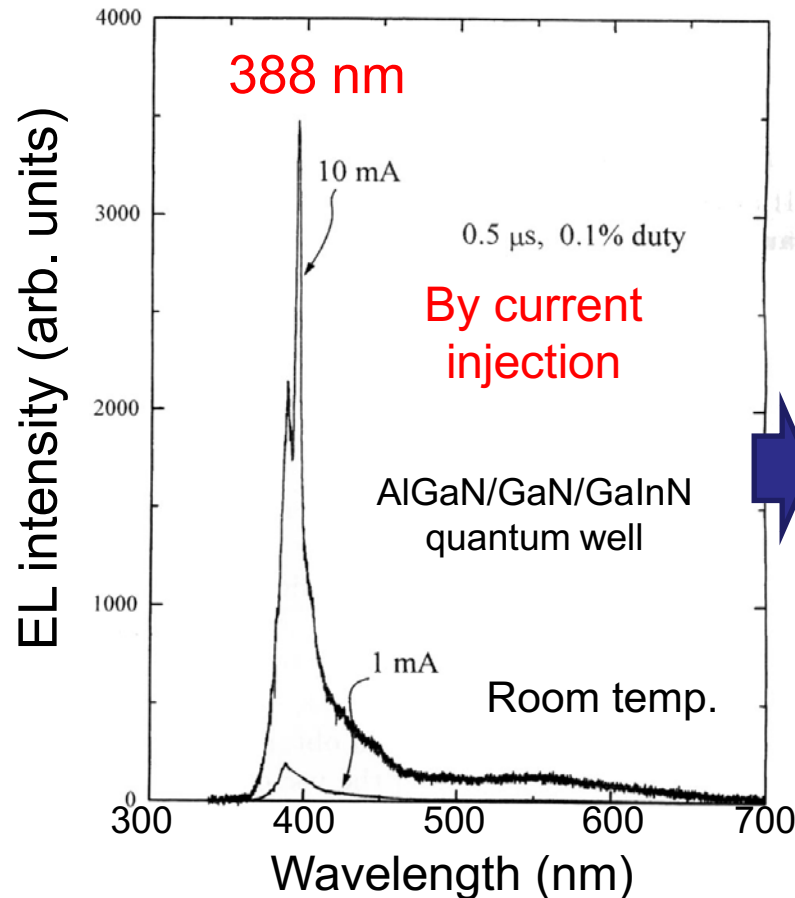
GaN-based laser



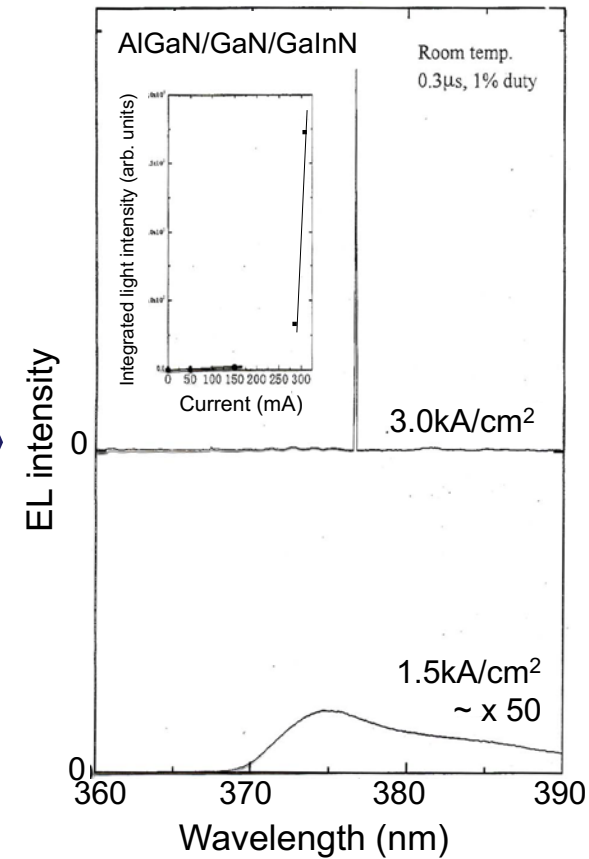
Stimulated emission by
optical pumping (1990)



Stimulated emission by
current injection (1995)

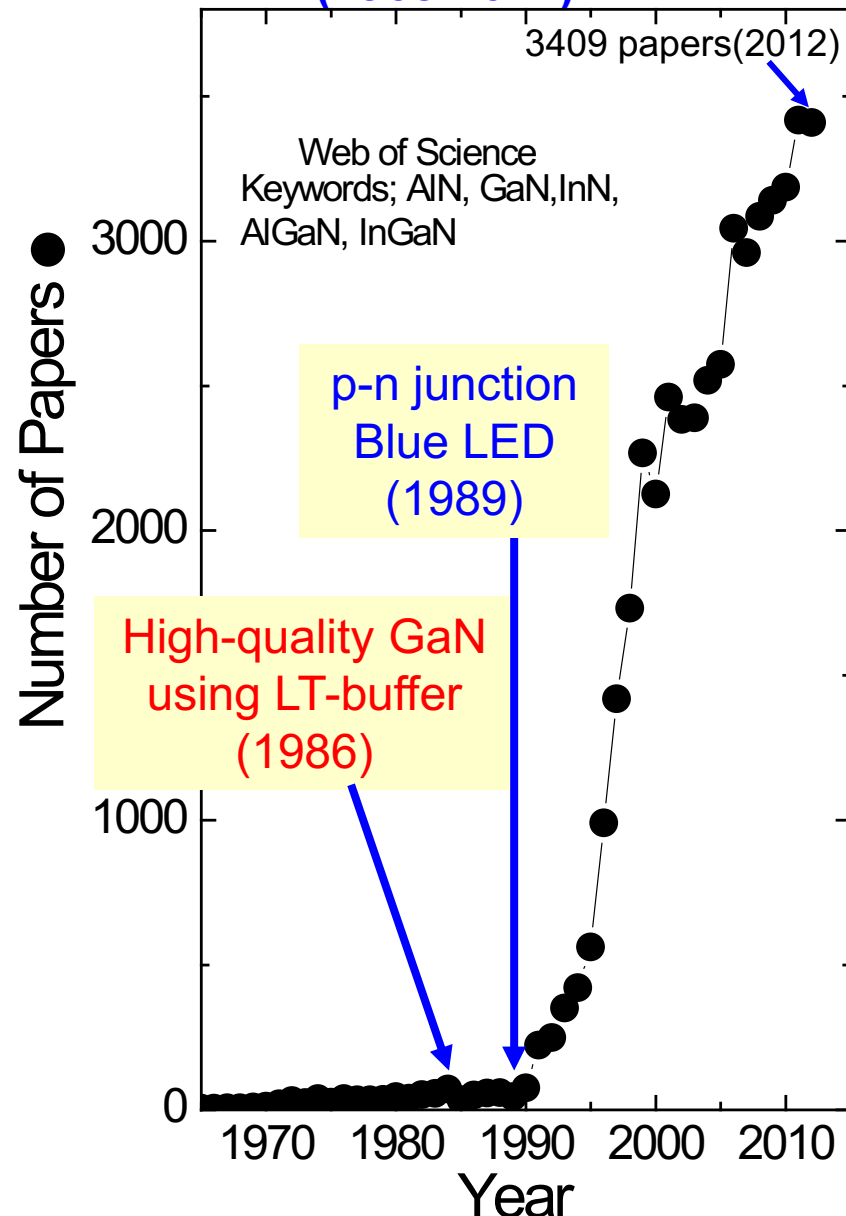


UV (376 nm) Laser diode
(1996)



On the basis of the technologies of LT-buffer layer and p-n junction heterostructures, GaN-based lasers were achieved

Number of Papers Related to Nitrides (1965-2012)



Distinguished Important Achievements

- 1969 Single crystal GaN (H. P. Maruska et al.)
- 1971 MIS-type Blue LED (J. I. Pankove et al.)
- 1986 High-quality GaN single crystal grown with LT-buffer layer by MOVPE
- 1989 GaN p-n junction Blue LED
- 1989 Conductivity control of p- and n-type GaN
- 1990 Room temperature UV stimulated emission from GaN by optical pumping
- 1990 Growth of GaInN (T. Matsuoka et al.)
- 1991 p-type GaN by thermal annealing (S. Nakamura et al.)
- 1993 GaInN double hetero-junction Blue LED (S. Nakamura et al.)
- 1995 Stimulated emission from GaInN/GaN quantum wells by current injection
- 1996 Violet laser diode (S. Nakamura et al.)
- 1996 UV laser diode

Red characters: Akasaki and Amano group

- While many researchers abandoned the development of GaN Blue LED, I have been fascinated with the research on GaN-based semiconductors, since 1973.
- Through persistent efforts, with the collaboration of Hiroshi Amano, Yasuo Koide, and many students/coresearchers over many years, we invented high-quality GaN single crystal in 1986, and GaN p-n junction Blue LED in 1989.
- GaN-based photonic & electronic devices are environmentally-sound, robust, and energy-saving, which benefit humanity.

Acknowledgements

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